

| | | | |
|-----------------------------------|---------------------------------------|--|-------------|
| Notice of References Cited | Application/Control No. 10/713,491 | Applicant(s)/Patent Under Reexamination LIU, YAN | |
| | Examiner Mirellys Jagan | Art Unit 2859 | Page 1 of 3 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------|----------------|
| | A | US- | | | |
| | B | US- | | | |
| | C | US- | | | |
| | D | US- | | | |
| | E | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|----------------|----------------|
| | N | JP 57000532 A | 01-1982 | Japan | TAGAMI, ICHIZO | G01J 03/02 |
| | O | JP 56033518 A | 04-1981 | Japan | TAGAMI, ICHIZO | G01J 05/60 |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|--|
| | U | Shand et al., "Temperature Dependence of the Excited-State Absorption of Alexandrite", IEEE Journal of Quantum Electronics, Vol. QE-19, No. 3, pp. 480-484, March 1983. |
| | V | Augousti et al., "A Laser- Pumped Temperature Sensor Using the Fluorescent Decay Time of Alexandrite", Journal of Lightwave Technology", Vol. LT-5, No. 6, pp. 759-762, June 1987. |
| | W | Alcala et al., "Real Time Frequency Domain Fiberoptic Temperature Sensor", IEEE Transactions on Biomedical Engineering", Vol. 42, No. 5, pp. 471-476, May 1995. |
| | X | Bukin et al., "Growth of Alexandrite Crystals and Investigation of Their Properties", Journal of Crystal Growth, vol. 52, pp. 537-541, 1981. |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

| | | | |
|-----------------------------------|---------------------------------------|--|-------------|
| Notice of References Cited | Application/Control No. 10/713,491 | Applicant(s)/Patent Under Reexamination LIU, YAN | |
| | Examiner Mirellys Jagan | Art Unit 2859 | Page 2 of 3 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------|----------------|
| | A | US- | | | |
| | B | US- | | | |
| | C | US- | | | |
| | D | US- | | | |
| | E | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|--|
| | U | Farmer, "Plasma Temperature Measurement", Handbook of Temperature Measurement: Temperature and Humidity Measurement, Vol. 1, pp. 119-131, 1998. |
| | V | Liu et al., "The 'Alexandrite Effect' in Gemstones", Color Research & Application, vol. 19, No.3, pp. 186-191, June 1994. |
| | W | Liu et al., "Relationship Between the Crystallographic Orientation and the 'Alexandrite Effect' in Synthetic Alexandrite", Mineralogical Magazine, vol. 59, pp. 111-114, March 1995. |
| | X | Liu et al., "Abnormal Hue-angle Change of the Gemstone Tanzanite between CIE Illuminants D65 and A in CIELAB Color Space", Color Research & Application, vol 20, No 4, pp. 245-250, August 1995. |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

| | | | |
|-----------------------------------|---------------------------------------|--|-------------|
| Notice of References Cited | Application/Control No. 10/713,491 | Applicant(s)/Patent Under Reexamination LIU, YAN | |
| | Examiner Mirellys Jagan | Art Unit 2859 | Page 3 of 3 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------|----------------|
| | A | US- | | | |
| | B | US- | | | |
| | C | US- | | | |
| | D | US- | | | |
| | E | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | Michalski et al., Temperature Measurement, 2nd ed. Wiley & Sons, pp. 151-228, 2001. |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.